

IGBT4 High Power Chip

FEATURES:

- 1200V Trench + Field Stop technology
- Iow V_{CEsat}
- soft turn off
- positive temperature coefficient
- easy paralleling

This chip is used for:

• medium / high power modules

medium / high power drives



Chip Type	V _{CE}	I Cn	Die Size	Package
IGC142T120T6RH	1200V	150A	11.31 x 12.56 mm ²	sawn on foil

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Applications:

MECHANICAL PARAMETER

Raster size	11.31 x 12.56			
Emitter pad size (incl. gate pad)	11.04 x 9.80	mm ²		
Gate pad size	1.31 x 0.81			
Area total / active	142.1 / 113.1			
Thickness	140			
Wafersize	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	94			
Passivation frontside	Photoimide			
Pad metal	3200 nm AlSiCu			
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding			
Diebond	Electrically conductive glue or solder			
Wire bond	Al, <500µm			
Reject ink dot size	Ø 0.65mm ; max 1.2mm			
Recommended storage environment	Store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, Tj=25 °C	V _{CE}	1200	V	
DC collector current, limited by T _{jmax}	I _C	1)	А	
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	450	А	
Gate - Emitter voltage	V _{GE}	±20	V	
Operating junction temperature	Tj	-40 +175	°C	
Short circuit data ² V \approx = 15V, V \propto = 800V, Tvj = 150°C	tp	10	μs	
Reverse bias safe operating area ²⁾ (RBSOA)	$I_{C max}$ = 300A, $V_{CE max}$ = 1200V, Tvj max= 150°C			

¹⁾ depending on thermal properties of assembly

²⁾ not subject to production test - verified by design/characterization

STATIC CHARACTERISTICS (tested on wafer), $\mathit{T_{j}}\text{=}25~^{\circ}\text{C}$

Parameter	Symbol	Conditions	Value			Unit
	Cymber	Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I _C = 6 mA	1200			
Collector-Emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =150A	1.5	1.7	2.0	V
Gate-Emitter threshold voltage	V _{GE(th)}	I_{C} =6mA , V_{GE} = V_{CE}	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =1200V , V_{GE} =0V			20	μA
Gate-Emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			600	nA
Integrated gate resistor	R _{Gint}			5		Ω

ELECTRICAL CHARACTERISTICS (not subject to production test - verified by design/characterization)

Parameter	Symbol	Conditions	Value			Unit
	Symbol	Conditions	min.	typ.	max.	Onic
Input capacitance	Ciss	V _{CE} =25V,		9300		
Output capacitance	Coss	$V_{GE} = 0 V$,		580		рF
Reverse transfer capacitance	Crss	f=1MHz		510		



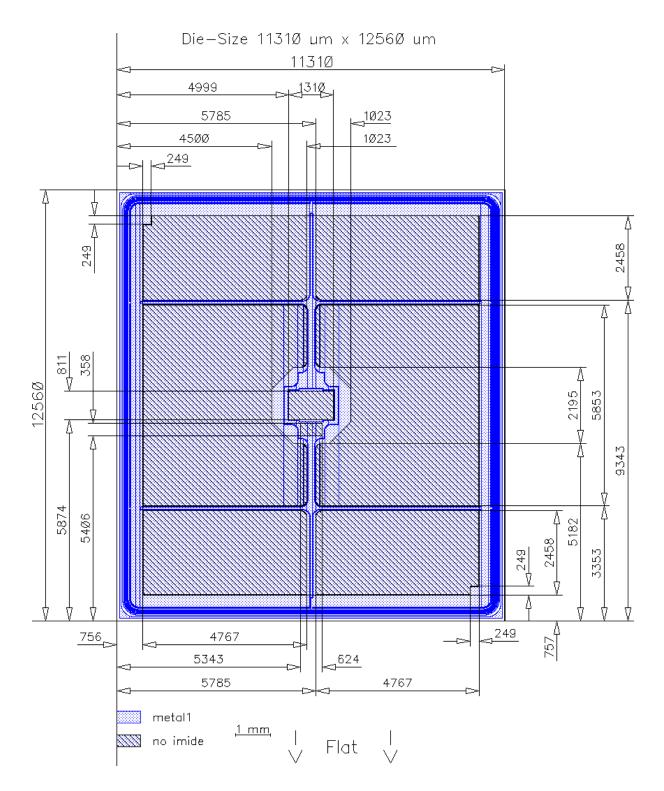
SWITCHING CHARACTERISTICS inductive load (not subject to production test - verified by design /characterization)

Parameter	Symbol	Conditions ¹⁾	Value			Unit
	Gymbol		min.	typ.	max.	
Turn-on delay time	t _{d(on)}	$T_j = 125^{\circ}C$ $V_{CC} = 600V$, $I_C = 150A$, $V_{GE} = -15/15V$,		tbd		
Rise time	<i>t</i> r			tbd		ns
Turn-off delay time	t _{d(off)}			tbd		115
Fall time	t _f	R _G =Ω		tbd		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING



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FURTHER ELECTRICAL CHARACTERISTICS

This chip data sheet refers to the device data sheet	tbd	

DESCRIPTION

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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